

Dependence of transverse magneto-thermoelectric effects on inhomogeneous magnetic fields

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Transverse magneto-thermoelectric effects are studied in permalloy thin films grown on MgO substrates. We find that small parasitic magnetic fields below 1 Oe can produce artifacts of the order of 1% of the amplitude of the anisotropic magneto-thermopower which is also detected in the experiments. The measured artifacts reveal a new source of uncertainties for the detection of the transverse spin Seebeck effect. Taking these results into account we conclude that the contribution of the transverse spin Seebeck effect to the detected voltages is below the noise level of 20 nV.

I. INTRODUCTION

The rapidly evolving field of spin caloritronics [1, 2] has attracted a lot of attention in the past years. Particularly, the transverse spin Seebeck effect (TSSE), at first sight a seemingly simple effect to measure, has been the target of many experimentalists. However, it turned out that the TSSE [3–16], especially when using metallic ferromagnets [3–7, 13, 15, 16], is under strong discussion. Other magneto-thermoelectric effects, like the anomalous Nernst effect (ANE) [6, 7, 15–17] and the anisotropic magneto-thermopower (AMTEP, also known as the planar Nernst effect (PNE)) [4, 15, 16, 18, 19] play an important role in the TSSE measurements and contribute to the detected signals. ANE and TSSE signals are antisymmetric with respect to the external magnetic field, have the shape of hysteresis loops and both follow the $\cos\Theta_0$ dependence, where Θ_0 is the angle between the magnetization vector $\vec{M}$ and the temperature gradient $\vec{\nabla}T$. The AMTEP can be identified by its $\sin 2\Theta_0$ angular dependence and symmetric shape. Thus, it was postulated that the ANE caused by an unintended out-of-plane temperature gradient (due to heat flux into surrounding area by radiation [15] and through electrical contacts by thermal conductivity [16]) is the main effect masking TSSE in metallic ferromagnets. Small static environmental magnetic fields of the Earth magnetic field's order of magnitude and lower are typically not considered in experimental set-ups. However, in nanovolt range signal measurements this fields could lead to unexpected effects those are mask or mimic the investigated effect. In this article we show that the AMTEP generated by solely in-plane $\vec{\nabla}T$ in presence of very small static parasitic magnetic field can produce an significant antisymmetric artifact that shares the $\cos\Theta_0$ dependence with the ANE and TSSE. Therefore, the third source of uncertainties is found for TSSE experiments which then could lead to wrong interpretations of the observed data.

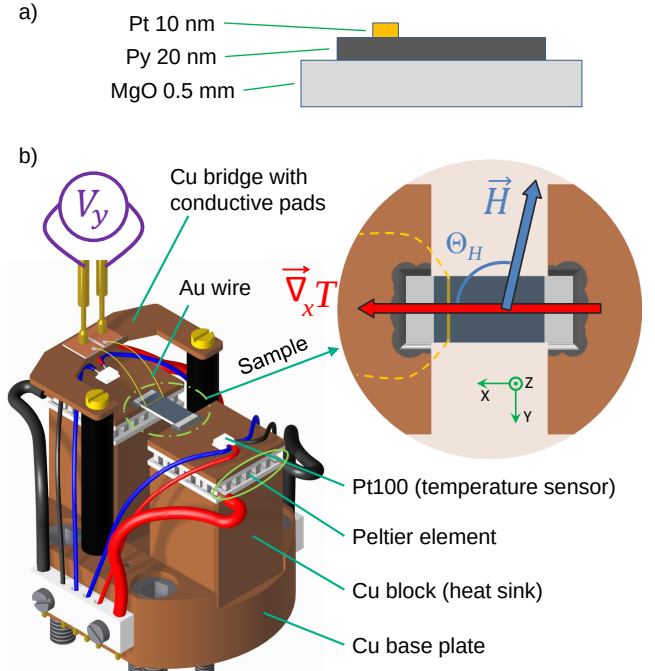


FIG. 1. a) Sample parameters: 0.5 mm thick MgO substrate (area of $10 \text{ mm} \times 4 \text{ mm}$), 20 nm thick Py film (area of $6 \text{ mm} \times 4 \text{ mm}$) on top of the substrate and 10 nm thick Pt strip ($0.1 \text{ mm} \times 4 \text{ mm}$) grown on the Py film. b) Sample holder: Two Cu blocks are attached to a common Cu base plate, and carry the Peltier elements with Pt100 temperature sensors attached to them (these sensors measure the temperatures T_1 and T_2 , see Appendix A). Close-up: The sample is connected by thermally conductive glue to the Cu interfaces of the Peltier elements, which produce the temperature gradient $\vec{\nabla}_x T$. The external magnetic field $H = -44.. + 44 \text{ Oe}$ is applied in the x-y plane with the angle Θ_H in reference to the x-axis.

II. SAMPLE PROPERTIES AND EXPERIMENTAL SET-UP

A 20 nm thick permalloy film (fig. 1a) with area of $6 \text{ mm} \times 4 \text{ mm}$ is deposited onto a 0.5 mm thick MgO substrate (area of $10 \text{ mm} \times 4 \text{ mm}$) using sputter deposition.

To detect the expected pure spin current via the inverse spin Hall effect [20–22] a 10 nm thick Pt strip is deposited in-situ through a shadow mask onto the Py film.

In fig. 1b the sample holder is shown. A Cu base plate holds two Cu blocks (heat sinks). Peltier elements are attached to each Cu block. The sample is glued onto the Cu pads, which are mounted as heat sinks onto the Peltier elements. The Peltier elements provide a controlled temperature gradient in the sample plane along the x-axis (see close-up in the inset in fig. 1b). The temperatures of the Peltier elements are measured with Pt100 temperature sensors. The temperature value at the position of the Pt strip T_{str} is used as the base temperature. For details concerning the determination of T_{str} and the temperature difference on the sample ΔT_x see Appendix A. 20 μm thin Au wires are glued to the ends of the Pt strip detector to provide electrical contacts to a nano-voltmeter. Opposite ends of the Au wires are glued to conductive pads of a Cu bridge, where a voltage signal gets picked up by two spring contacts. The conductive pads are electrically isolated one from another and from the Cu bridge.

Measurements are performed in a vacuum chamber (see fig. 2) at a base pressure $2 \cdot 10^{-6}$ mbar to prevent influence of convection and thermal conductivity of air. The external magnetic field with values between $H = -44..+44$ Oe is produced by Helmholtz coils, which can be rotated around the fixed measuring chamber. The magnetic field is applied in the x-y plane of the sample with angles in steps of 30° ($\Theta_H = 0^\circ, 30^\circ, \dots, 360^\circ$, see close-up in fig. 1b) with respect to the x-axis.

III. EXPERIMENTAL DATA

In fig. 3 we show a typical set of experimental data of the voltages $V_y(H)$ (green lines) measured across the Pt strip for the following parameters: base temperature $T_{str} = 360$ K; temperature difference on the sample $\Delta T_x = 28$ K ($\sim \nabla_x T = 4.7$ K/mm); sweeping field angles $\Theta_H = 0^\circ, 30^\circ, \dots, 360^\circ$. The red dots shown on the left and right side of each green curve represent two averaged values of $V_y(H)$: for $H = -44..-40$ Oe and $H = 40..44$ Oe, respectively. From these two values we find the mean value $A(\Theta_H)$ and the difference value $\Delta(\Theta_H)$. $A(\Theta_H)$ with magnitude A_0 is indicated by the blue dots and the blue dashed line, $\Delta(\Theta_H)$ with magnitude Δ_0 is shown in the inset.

The peaks visible in the $V_y(H)$ curves as well as the $\sin 2\Theta_H$ dependence of $A(\Theta_H)$ are related to the AMTEP, for details see [15, 16]. The transverse voltage, associated with the AMTEP traces, can be described as:

$$V_y(H) - V_{offset} = A_0(\Delta T_x) \sin 2\Theta_0(H) \propto \left| \vec{M} \right|^2 \left| \vec{\nabla}_x T \right| \sin 2\Theta_0(H), \quad (1)$$

where Θ_0 is the angle between the temperature gradient $\vec{\nabla}_x T$ and the magnetization vector $\vec{M}$; A_0 is the

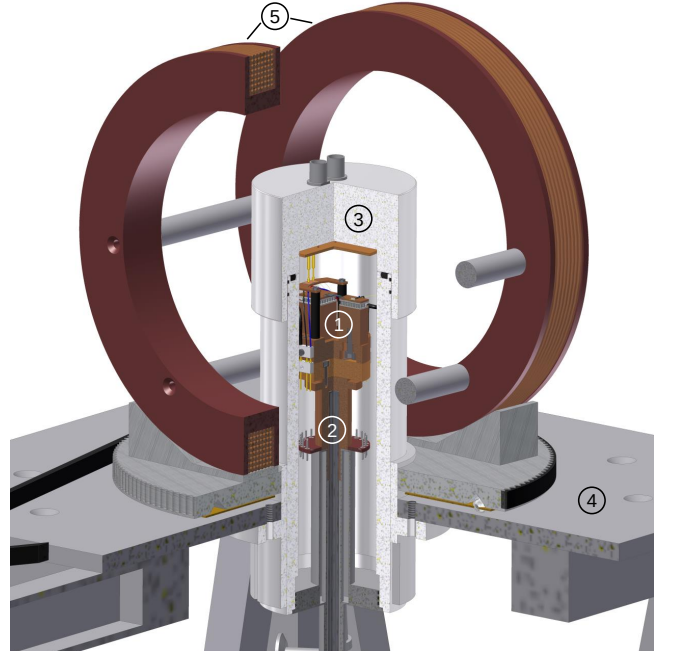


FIG. 2. Set-up: The sample holder (1) rests on a pillar (2) and is placed in the middle of the vacuum chamber (3) without contact to its walls. The vacuum chamber is mounted onto a table (4) and fixed rigidly. Helmholtz coils (5) surround the vacuum chamber and are able to rotate around it. Additionally, an Al shield (not shown here) covers the whole set-up. This shield is used to decrease external temperature variations and electro-magnetic noise during the measurements.

AMTEP amplitude; V_{offset} is the voltage signal produced in the Au wires due to the conventional charge Seebeck effect (for details see Appendix B). The peaks in $V_y(H)$ are caused by the alignment procedure of the magnetization $\vec{M}$ parallel to the magnetic easy axis of the Py film [16]. The easy axis of the sample has an angle of $\varphi \approx 35^\circ$ with respect to the x-axis of the sample. For angles of the sweeping field $\Theta_H = 30^\circ, 60^\circ, 210^\circ, 240^\circ$ we observe the smallest peaks in the AMTEP curves since the easy axis is close to the direction of the sweeping field $\vec{H}$. When the values of H are large enough to saturate the sample, the magnetization direction angle Θ_0 is very close to the angle Θ_H of the applied magnetic field. In this case the mean values A should follow the $\sin 2\Theta_H$ dependence as can be seen for the blue dashed line.

The difference signal $\Delta(\Theta_H)$ has a $\cos \Theta_H$ dependence (see inset in fig. 3). Its amplitude Δ_0 can be interpreted as a mixture of TSSE and ANE signals, where the ANE is produced by a spurious out-of-plane temperature gradient $\vec{\nabla}_z T$ [15].

In fig. 4a we replot the Δ_0 experimental data that was published in [15]. These measurements have been performed for fixed temperature differences $\Delta T_x = -25, 0, +25$ K ($\nabla_x T = -4.2, 0, 4.2$ K/mm) and as a function of base temperature T_{str} . The slope of the Δ_0 lines of fixed temperature differences $\Delta T_x = -25, 0, +25$ K

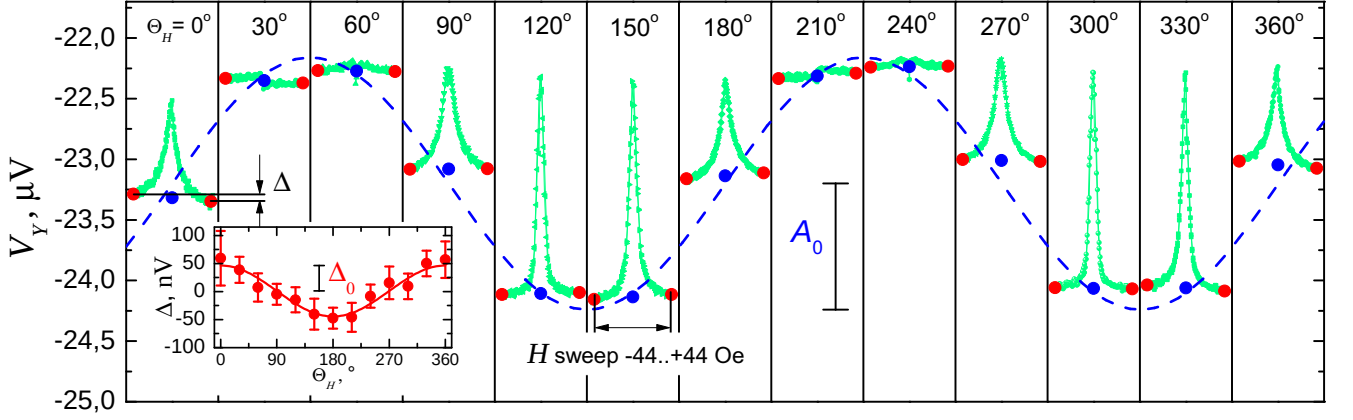


FIG. 3. Set of transverse voltages $V_y(H)$ (green traces) for temperature difference $\Delta T_x = 28$ K ($\sim \nabla_x T = 4.7$ K/mm), base temperature $T_{str} = 360$ K and different Θ_H . The average values A (blue dots and blue dashed line) follow a $\sin 2\Theta_H$ dependence with amplitude A_0 as expected from a contribution of the AMTEP. The difference values Δ (inset, red dots) shows a $\cos \Theta_H$ dependence with amplitude Δ_0 . This $\cos \Theta_H$ dependence could be associated with both TSSE and ANE.

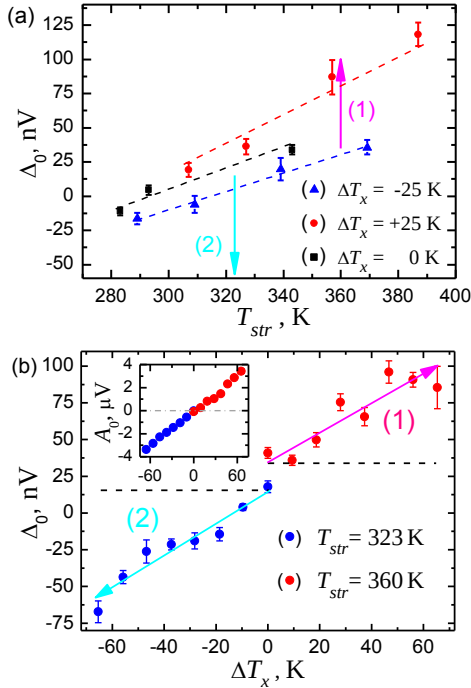


FIG. 4. a) Dependence of the difference signal amplitude Δ_0 on the base temperature T_{str} for fixed temperature differences $\Delta T_x = -25, 0, 25$ K ($\sim \nabla_x T = -4.2, 0, 4.2$ K/mm respectively) taken from [15]. b) Dependence of the amplitude of the difference signal Δ_0 on the temperature difference ΔT_x for fixed base temperatures $T_{str} = 323$ K (blue dots and light blue arrow) and 360 K (red dots and magenta arrow). The data shown in b) is represented in a) as the numbered arrows 1 (magenta) and 2 (light-blue). The inset represents the dependence of the AMTEP magnitude A_0 on ΔT_x and shows that at $\Delta T_x = 0$ K A_0 is 0 V within the uncertainty range. This means that no in-plane temperature gradient is generated.

(dashed lines in fig. 4a) was explained in [15] as a contribution of ANE produced by a spurious $\vec{\nabla}_z T$ gradient due to surface-to-surface radiation heat transfer between the sample and the vacuum chamber ($\nabla_z T \propto (T_{room} - T_{str})^2$, where T_{room} is the ambient temperature of the laboratory). At first sight, the shifts of the "undisturbed" line for $\Delta T_x = 0$ K (up for a positive temperature gradient and down for a negative one) are expected to be related to TSSE. However, after having performed control measurements on samples where we have replaced the Pt detector strip with a Cu strip we found that the vertical shift is not related to the TSSE, but at this point its origin was an open question [15].

To clarify the nature of these shifts, we compare the data to additional measurements of Δ_0 for a fixed T_{str} and varying ΔT_x (see fig. 4b). Here we use $T_{str} = 360$ K for the strip being located at the hot side and $T_{str} = 323$ K for it being located at the cold side. The inset in fig. 4b proves that no in-plane temperature gradient is generated at the point $\Delta T_x = 0$ K, since the AMTEP amplitude $A_0(\Delta T_x = 0$ K) is equal to 0 V within the uncertainty range. Note that the black dashed lines in fig. 4b indicate that $\Delta_0(\Delta T_x = 0$ K) is not equal to 0 V for both $T_{str} = 360$ K and $T_{str} = 323$ K. This is caused by an ANE signal, since the base temperatures T_{str} differs from T_{room} (compare to the line for $\Delta T_x = 0$ K in fig. 4a). The experimental data shown in fig. 4b is in addition represented in fig. 4a as the numbered arrows. We note that the data matches the previously observed experimental findings: Δ_0 increases with positive temperature gradients and decreases with negative temperature gradients.

Next we take a more precise look at the evolution of the $\Delta(\Theta_H)$ traces as a function of ΔT_x . Fig. 5 reveals a new, non cosine-like contribution to the $\Delta(\Theta_H)$ signal. This contribution becomes even more obvious for larger temperature gradients $\nabla_x T$. We will show in the follow-

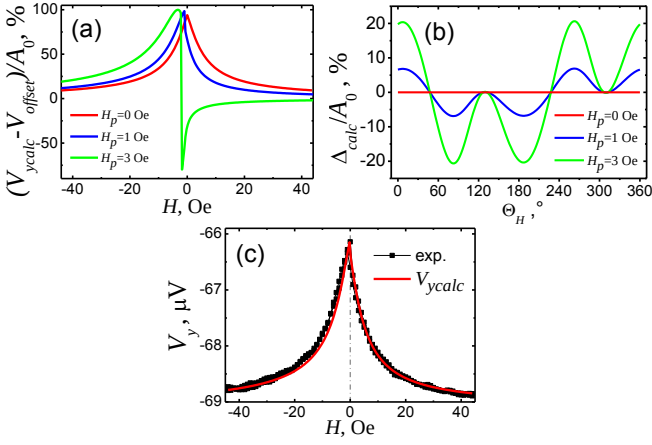


FIG. 7. Appearance of an asymmetry in the AMTEP curves: a) Calculated AMTEP curves $(V_{ycalc}(H) - V_{offset})/A_0$ for $\Theta_H = 0^\circ$ and $H_p = 0, 1, 3$ Oe; b) Calculated difference signals $\Delta_{calc}(\Theta_H)$ related to $V_{ycalc}(H)$ from figure a; c) Experimental curve $V_y(H)$ for $T_{str} = 360$ K, $\Delta T_x = 65$ K ($\sim \nabla_x T = 11$ K/mm), $\Theta_H = 0^\circ$ and calculated curve $V_{ycalc}(H)$ for $H_p = 0.28$ Oe (the measured parasitic field in the current set-up).

4. We repeat steps 1.-3. for $\Theta_H = 0^\circ..360^\circ$. Finally, we calculate the AMTEP artifact difference signal $\Delta_{calc}(\Theta_H) = V_{ycalc}(\Theta_H, -H_{max}) - V_{ycalc}(\Theta_H, H_{max})$.

Fig. 7a shows that the calculated AMTEP curves $(V_{ycalc}(H) - V_{offset})$ shift and become asymmetric as the parasitic field $\vec{H}_p$ appears. The curves become actually antisymmetric for moderately high values of H_p (> 2 Oe). We should note that a change of symmetry appears only if $\vec{H}_p \nparallel \vec{H}$, otherwise only a shift of the AMTEP curves can be observed. However, a difference signal $\Delta_{calc}(\Theta_H) \neq 0$ caused by the parasitic field must be introduced, since $V_{ycalc}(H_{max}) \neq V_{ycalc}(-H_{max})$ due to the induced shift. Fig. 7b presents the AMTEP artifact difference signals $\Delta_{calc}(\Theta_H)$, related to the curves from fig. 7a. The artifact's magnitude obviously scales with the parasitic field value H_p and in absence of a parasitic field the difference signal $\Delta_{calc}(\Theta_H)$ does not appear.

The good match of the experimental data $V_y(H)$ with the calculation $V_{ycalc}(H)$ for $H_p = 0.28$ Oe (the value of the parasitic field in our set-up) can be seen in fig. 7c. The parameters [25] of our set-up are used for all calculations in fig. 7. To verify the accuracy of the computational model we perform measurements with large static parasitic magnetic field (several 10s of Oe, in this case AMTEP curves should be antisymmetric). A small permanent magnet was glued to the wall on the outside of the vacuum chamber and at the same height with the sample. The value and direction of the magnetic field at the position of the sample are determined with a Hall probe. One of the measurements for $H_p = 19 \pm 2$ Oe, $\alpha = -80 \pm 3^\circ$, $T_{str} = 323$ K and $\Delta T_x = 28$ K is shown

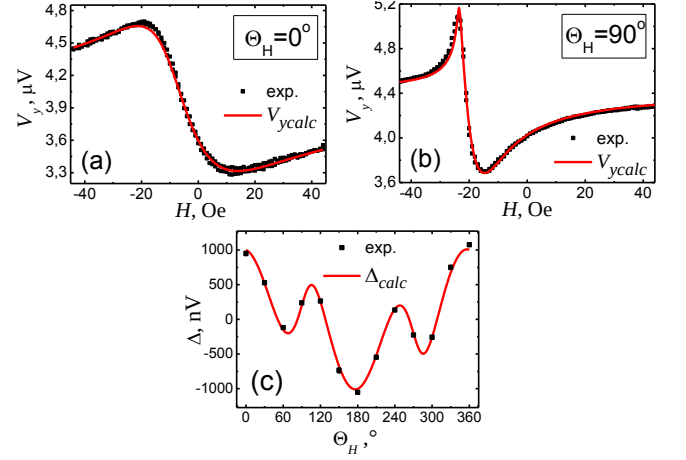


FIG. 8. Experiments with large static parasitic magnetic field $H_p = 19 \pm 2$ Oe with angle $\alpha = -80 \pm 3^\circ$ for $T_{str} = 323$ K and $\Delta T_x = 28$ K ($\sim \nabla_x T = 4.7$ K/mm). Experimental $V_y(H)$ in comparison with calculated $V_{ycalc}(H)$: a) Angle of the sweeping magnetic field $\Theta_H = 0^\circ$; b) $\Theta_H = 90^\circ$. c) Experimental $\Delta(\Theta_H)$ in comparison with calculated artifact $\Delta_{calc}(\Theta_H)$.

in fig. 8. Fig. 8a and fig. 8b present a comparison of the calculated dependencies $V_{ycalc}(H)$ with the experimental $V_y(H)$ for angles of the sweeping field $\Theta_H = 0^\circ$ and 90° . Fig. 8c, in turn, presents a comparison of the calculated dependence $\Delta_{calc}(\Theta_H)$ with the experimental $\Delta(\Theta_H)$. The calculated traces $V_{ycalc}(H)$ and $\Delta_{calc}(\Theta_H)$ nearly perfectly reproduce the experimental traces $V_y(H)$ and $\Delta(\Theta_H)$, respectively. A very small difference between $\Delta_{calc}(\Theta_H)$ and $\Delta(\Theta_H)$ due to contributions of ANE and TSSE signals to the experimental data are barely visible, since their magnitudes are by 2 orders smaller than artifact's magnitude.

In fig. 9 we present the calculated difference signal $\Delta_{calc}(\Theta_H)$ (normalized by A_0) for the parameters [25] of the current experimental set-up. $\Delta_{calc}(\Theta_H)$ is in good agreement with the experimental curve $\Delta(\Theta_H)$ shown in fig. 5c for a large temperature difference of $\Delta T_x = 56$ K. The divergence of $\Delta(\Theta_H)$ from $\Delta_{calc}(\Theta_H)$ is caused by an additional cosine contribution of the ANE signal (with magnitude of ≈ 35 nV) to experimental data $\Delta(\Theta_H)$.

Since we use numerical calculations, we cannot extract a functional dependence from $\Delta_{calc}(\Theta_H)$. However, using a fit function:

$$\Delta(\Theta_H)_{fit} = \Delta_{AMTEP} \cos \Theta_H + E \sin(\Theta_H + \phi_1) \cos(2\Theta_H + \phi_2) \quad (4)$$

we can match our calculations with less than 10% error, $R^2 = 0.99$. Here $\Delta_{AMTEP} = 4A_0(\Delta T_x) \frac{H_p}{H_{max}} \sin(-\alpha)$ is the amplitude of the cos-like part of the artifact, where H_{max} is the maximum value of the applied magnetic field; $E = 4A_0(\Delta T_x) \frac{H_p}{H_{max}}$ is the amplitude of the non-cos-like part of the artifact; phase $\phi_1 = 0^\circ$; phase $\phi_2 = -\alpha$. The fit function (4) describes the behavior of the

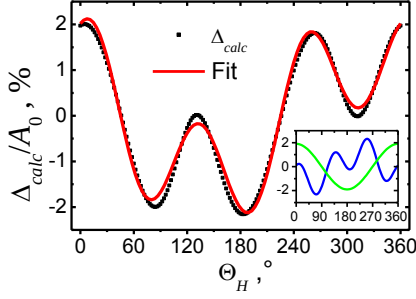


FIG. 9. $\Delta_{calc}(\Theta_H)$ computed for the parameters of the experimental set-up [25]. The red line is a fit to equation (4). Artifacts of $\approx 2\%$ of the AMTEP amplitude A_0 are found. The inset presents the extracted fitted parts of the $\Delta_{calc}(\Theta_H)$ signal: $\Delta_{AMTEP} \cos(\Theta_H)$ (green line) and $E \sin(\Theta_H + \phi_1) \cos(2\Theta_H + \phi_2)$ (blue line). The fit curve deviates from the $\Delta_{calc}(\Theta_H)$ by less than 10% of its amplitude, $R^2 = 0.99$.

difference signal $\Delta_{calc}(\Theta_H)$ very well until the conditions $\frac{H_p}{H_{max}} \ll 1$ and $\frac{H_a}{H_{max}} \ll 1$ are satisfied. The anisotropy field H_a and its orientation angle φ keep the shape of the calculated curve nearly undisturbed, until $\frac{H_a}{H_{max}} \ll 1$. The larger becomes $\frac{H_a}{H_{max}}$, the more the parameters Δ_{AMTEP} , E , ϕ_1 and ϕ_2 deviate from the values defined above. After a certain point ($\frac{H_a}{H_{max}} \approx \frac{1}{2}$) the difference signal $\Delta_{calc}(\Theta_H)$ gets peaks, its shape changes strongly and it cannot be described with function (4) anymore. Angle α of a parasitic magnetic field strongly defines the phase ϕ_2 and the amplitude Δ_{AMTEP} : when $\vec{H}_p \parallel \vec{\nabla}_x T$ ($\alpha = 0^\circ$) $\Delta_{AMTEP} = 0$ V; when $\vec{H}_p \perp \vec{\nabla}_x T$ ($\alpha = 90^\circ$) Δ_{AMTEP} has a maximum value. When $\frac{H_p}{H_{max}} \gg 1$ the shape of the difference signal $\Delta_{calc}(\Theta_H)$ transforms from function (4) into $-\sin(\Theta_H + \phi_2)$. As shown in the inset of fig. 9, artifact $\Delta_{calc}(\Theta_H)$ contains a significant cosine-like contribution that can be mistaken for a TSSE or ANE contribution.

The shape of the AMTEP artifact $\Delta_{calc}(\Theta_H)$ does not depend on ΔT_x , but its magnitude scales linearly with ΔT_x . In this sense, the cosine-part of the artifact Δ_{AMTEP} has absolutely the same behavior as the TSSE. It shows the same angular dependence as TSSE and both effects are proportional to the temperature gradient $\nabla_x T$. The ANE, in turn, shares only the angular dependence with the TSSE.

Since we found a new fit function (4), we can use it to fit the experimental difference signals $\Delta(\Theta_H)$. We only replace Δ_{AMTEP} in (4) by Δ_0 , which in case of experimental data contains three contributions:

$$\Delta_0(T_{str}, \Delta T_x) = \underbrace{\propto T_{str}^2}_{\propto T_{str}^2} + \underbrace{\propto \Delta T_x}_{\propto \Delta T_x} + \Delta_{AMTEP}(\Delta T_x) + \Delta_{TSSE}(\Delta T_x), \quad (5)$$

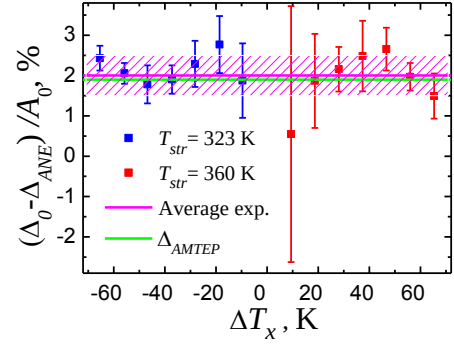


FIG. 10. Comparison of the experimental level $(\Delta_0 - \Delta_{ANE})/A_0$ (blue and red points, magenta line with shaded area presents averaged experimental data) with the normalized calculated AMTEP artifact Δ_{AMTEP}/A_0 (green line). Large deviations of the experimental points from the average value in the region of small differences ΔT_x are connected to small values of the $\Delta_0 - \Delta_{ANE}$ and are proportionally impacted by noise.

where Δ_{AMTEP} is the cosine-part of the AMTEP artifact, Δ_{ANE} the contribution of the ANE due to a spurious out-of-plane temperature gradient $\vec{\nabla}_z T$ and Δ_{TSSE} the contribution of the TSSE. The phases ϕ_1 and ϕ_2 in (4) are extracted from the $\Delta_{calc}(\Theta_H)$ in fig. 9 (which computed for actual set-up parameters [25]) and are then kept constant in (4) for fitting the experimental data.

V. INTERPRETATION OF THE EXPERIMENTAL RESULTS

The vertical shift of the line for $\Delta T_x = 0$ K seen in fig. 4a, when changing the temperature difference ΔT_x , is mostly caused by the AMTEP artifact. It can finally be proven by showing the data in fig. 10. The experimental data points are calculated by subtracting the ANE contribution $\Delta_{ANE} = \Delta_0(\Delta T_x = 0 \text{ K})$ from the experimental amplitude $\Delta_0(\Delta T_x)$, see eq. (5) (i.e. this points contain mixture of TSSE signal magnitude Δ_{TSSE} and cosine-part of AMTEP artifact Δ_{AMTEP}). The normalized amplitude of the calculated cosine-part of the AMTEP artifact amounts to $\Delta_{AMTEP}/A_0 = 1.9\%$ (green line). This value is in good agreement with the experimental value $(\Delta_0 - \Delta_{ANE})/A_0$ of $2 \pm 0.5\%$ (magenta line and shaded area). This means, that the maximum possible contribution of the TSSE inside the error bars is $< \pm 0.3$ nV/K ($\sim \pm 2 \cdot 10^{-12}$ V $\cdot$ m/K in terms of temperature gradient), which leads to ± 20 nV for the maximum achieved temperature differences $\Delta T_x = \pm 65$ K.

We have examined possible sources of parasitic magnetic fields in our set-up and found that a parasitic field $H_p = 0.28$ Oe is caused by external magnetic fields existent in the laboratory. We have also examined the magnetic field contribution from the Peltier elements and verified that it produces only an insignificant field of 0.03 Oe

maximum.

There are few possibilities to suppress the cos-part of the AMTEP artifact:

1. Increasing of the maximum value of the sweep field H_{max} , as the equilibrium angle Θ_0 will then be closer to the angle of the sweep field Θ_H . According to our calculations, the level of the artifact could be reduced from 2% of the AMTEP amplitude A_0 (equal to 70 nV for the highest temperature gradients $\nabla_x T = \pm 11$ K/mm) to 0.06% (equivalent to 2 nV $\ll$ than noise level of 20 nV) by increasing the H_{max} from 44 Oe to 2000 Oe. The level of the artifacts is inversely proportional to the H_{max} . Unfortunately, in our setup we have no possibility to produce high magnetic fields larger than 50 Oe.
2. Keeping the sweep field $\vec{H}$ parallel to the parasitic field $\vec{H}_p$ and rotating the sample together with the applied in-plane temperature gradient $\vec{\nabla}T$. In this case the symmetry of the AMTEP traces is not disturbed, but a horizontal shift of traces equal to the value H_p appear. After this shift is subtracted, no AMTEP artifact in the difference signal $\Delta(\Theta_H)$ will be observed. However, rotation of the vacuum chamber is in our case not feasible.
3. Keeping the parasitic field $\vec{H}_p$ parallel to the applied in-plane temperature gradient $\vec{\nabla}T$. With this alignment the cos-part of AMTEP artifact would be strongly suppressed. The lower is the ratio $\frac{H_a}{H_{max}}$ and the closer is φ to $n \cdot 90^\circ$ (where n is integer), the stronger is the suppression. However, the non-cos-part of AMTEP artifact will be not suppressed.
4. The best solution is to suppress H_p using additional compensating magnetic field.

VI. CONCLUSION

In this study we have shown that a small parasitic static magnetic field below 1 Oe can produce an AMTEP artifact with amplitude of 10-100 nV that contains a TSSE-like contribution. This artifact has the same order of magnitude as the previously found source of misinterpretations in the TSSE experiments - the ANE due to out-of-plane temperature gradient (produced by heat flux through electrical contacts [16] and by heat radiation to the surrounding area [15]). But in contrast to the ANE-based parasitic effects, the new artifact does depend on the applied in-plane temperature gradient. This fact makes it more difficult to separate from possible TSSE signal, and, consequently, it has to be seriously taken into account. We found that the investigated parasitic effect also gives us the missing explanation of the vertical shift observed in [15]. Finally, no TSSE signals larger than the noise level of 20 nV have been detected in permalloy thin films.

ACKNOWLEDGMENTS

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Appendix A: TEMPERATURE MEASUREMENTS

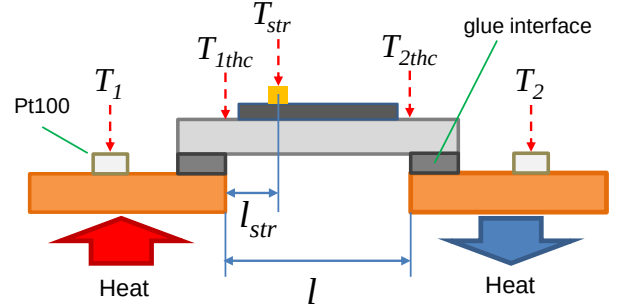


FIG. A.1. Definition of certain temperatures: T_1 and T_2 are temperatures of Peltier elements measured by temperature sensors Pt100; T_{str} is temperature at position of Pt strip; T_{1thc} and T_{2thc} are temperatures at the edges of suspended part of sample.

The effective temperature difference on the sample ΔT_x can be evaluated:

$$\Delta T_x = (1 - 2\alpha_t)(T_1 - T_2), \quad (\text{A.1})$$

where T_1 is the temperature measured with the Pt100 sensor on the Cu interface of the Peltier element that is closer to the Pt strip of the sample (see fig. A.1 - left heat sink with Pt 100 sensor on it), T_2 is the temperature measured on the second Peltier element, α_t is a dimensionless coefficient that describes temperature "losses" $\alpha_t(T_1 - T_2)$ on each of the glue interfaces between Peltier elements and sample. To find α_t we conduct measurements with 2 additional thermocouples of type K. Thermocouples are placed on top of the sample in the points T_{1thc} and T_{2thc} shown of fig. A.1. Difference between temperatures measured by these thermocouples gives us $\Delta T_x = T_{1thc} - T_{2thc}$. We assume that temperature changes linearly with distance from point with temperature T_{1thc} to point with temperature T_{2thc} . Thus:

$$T_{str} = T_{1thc} - \Delta T_x \frac{l_{str}}{l}, \quad (\text{A.2})$$

where l_{str} is the distance from point with T_{1thc} to the position of the Pt strip, l - distance between point with T_{1thc} and point with T_{2thc} . Since we fix certain T_{str} and

ΔT_x in our measurements, we need to know at which temperatures both Peltier elements should be kept. These temperatures can be calculated as follows:

$$\left. \begin{aligned} T_1 &= T_{str} + \Delta T_x \left(\frac{l_{str}}{l} + \frac{\alpha_t}{1 - 2\alpha_t} \right) \\ T_2 &= T_{str} - \Delta T_x \left(\frac{l - l_{str}}{l} + \frac{\alpha_t}{1 - 2\alpha_t} \right) \end{aligned} \right\} \quad (\text{A.3})$$

Appendix B: OFFSET VOLTAGE IN MEASUREMENTS

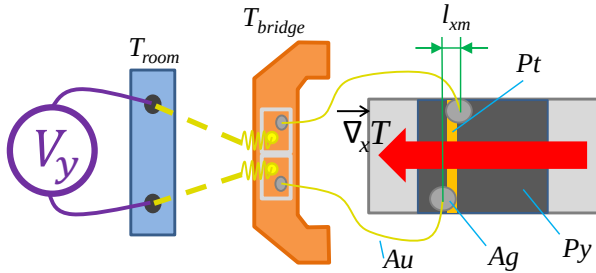


FIG. B.1. Appearance of thermoelectric signal in Au wires. Ends of Au wires those connected to voltmeter are kept at temperature T_{bridge} which is close to room temperature T_{room} . Opposite ends are glued to Pt strip. Small x-coordinate mismatch l_{xm} of centers of glue drops in presence of temperature gradient $\nabla_x T$ lead to temperature mismatch of these ends of Au wires.

The functional dependence of V_{offset} is given by:

$$V_{offset} = \alpha_1 \Delta T_x + \alpha_2 \Delta T_x (T_{str} - T_{room}), \quad (\text{B.1})$$

where T_{room} is room temperature, α_1 and α_2 are the effective first and second order coefficients of the conventional charge Seebeck effect. We found in our measurements $T_{room} \approx 296$ K, $\alpha_1 = -0.53 \mu\text{V/K}$ and $\alpha_2 = -4.6 \text{ nV/K}^2$. In this case the coefficients α_1 and α_2 are not only usual thermoelectric coefficients, but thermoelectric coefficients of Py/Ag interface multiplied by the geometrical mismatch coefficient $\frac{l_{xm}}{l}$, where l_{xm} is the x-projection of the distance between the centers of the glue drops that connect the Au wires with the Pt strip (see fig. B.1), l is the length of the suspended part of the sample (see fig. A.1). We consider a Py/Ag interface since Ag is the main component of the glue that connects the Au wires with the Pt strip of the sample and since the glue spots are distributed not only over the Pt strip, but also over the Py film. We take into account only the Py/Ag interfaces for the estimation of the thermoelectric coefficients since the Pt/Ag interfaces stay at the same temperature and produces no thermoelectric voltage. The thermoelectric voltage produced by the Au/Ag interface is 2 orders of magnitude smaller than the voltage produced by the Py/Ag interface. All other pairs of electrical interfaces, starting from the Cu bridge and finishing by the direct contacts of the nanovoltmeter, do not produce the thermoelectric voltage, since all pairs stay at the same temperatures.

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- [25] $H_p = 0.28$ Oe, $\alpha = -51^\circ$, $H_a = 4.5$ Oe, $\varphi = 35^\circ$, $H = -44..+44$ Oe. Since we perform averaging of the experimental V_y data points from ± 40 to ± 44 Oe, a range of $H = -42..+42$ is used for the simulation of $\Delta_{calc}(\Theta_H)$.